



**Fault Diagnosis and
Tolerance in Cryptography**

9th Workshop

on Fault Diagnosis and Tolerance in Cryptography

General Co-chairs:

Luca Breveglieri¹ and Israel Koren²

Program Co-chairs:

Guido Bertoni³ and Benedikt Gierlichs⁴

Invited papers Chair: David Naccache⁵

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- Proceedings by the IEEE CS Press
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2004-2012: Participation

#	Year	Location	Participants
1	2004	Florence, Italy	25
2	2005	Edinburgh, UK	118
3	2006	Yokohama, Japan	103
4	2007	Vienna, Austria	73
5	2008	Washington, USA	82
6	2009	Lausanne, Switzerland	95
7	2010	Santa Barbara, USA	100
8	2011	Nara, Japan	116
9	2012	Leuven, Belgium	103+

Submissions

- Manuscripts submitted: 20
- Accepted submissions: 10

Papers selection

- At least 3 reviewers per paper
- At least 5 reviewers for papers submitted by a member of the program committee
- 1 week of discussions following the completion of the review process

Participants

- France 28
- Germany 20
- Japan 15
- USA 10
- The Netherlands 4
- Belgium, Sweden, Israel 3
- Singapore, China 3
- Switzerland, Oman 2
- Italy, South Korea 2
- UK, Finland, Austria 1

Program co-chairs:

Guido Bertoni

STMicroelectronics,
Italy

Benedikt Gierlichs

KU Leuven,
Belgium

Invited talks chair:

David Naccache

École Normale
Supérieure de Paris,
France

Program committee:

- *Alessandro Barenghi, Politecnico di Milano, Italy*
- *Christophe Clavier, University of Limoges, France*
- *Wieland Fischer, Infineon Technologies, Germany*
- *Christophe Giraud, Oberthur Technologies, France*
- *Jorge Guarjardo, Bosch, USA*
- *Sylvain Guilley, Telecom ParisTech, France*
- *Helena Handschuh, Cryptography Research Inc., USA*
- *Dusko Karaklajic, KU Leuven, Belgium*
- *Kerstin Lemke-Rust, HBRS, Germany*
- *Marcel Medwed, UCL Crypto Group, Belgium*
- *Debdeep Mukhopadhyay, IIT Kharagapur, India*
- *Matthieu Rivain, CryptoExperts, France*
- *Jörn-Marc Schmidt, Technische Universität Graz, Austria*
- *Sergei Skorobogatov, University of Cambridge, UK*
- *Junko Takahashi, NTT Corporation, Japan*
- *Michael Tunstall, University of Bristol, UK*
- *Marc Witteman, Riscure, The Netherlands*

Special Thanks

Local arrangements provided by the
KU Leuven team headed by

Benedikt Gierlichs

In charge today: Oscar Reparaz

09:05-09:15	<p>Welcome and Opening Remarks <i>Israel Koren, Luca Breveglieri</i></p>
09:15-09:55	<p>1st Keynote Talk: <i>Chair: Sylvain Guilley</i> Techniques for EM Fault Injection: Equipment and Experimental Results <i>Philippe Maurine</i></p>
09:55-10:45	<p>Session 1: Fault injection and simulation <i>Chair: Kerstin Lemke-Rust</i> 1. Electromagnetic Transient Faults Injection on a Hardware and Software Implementation of AES <i>Amine Dehbaoui, Jean-Max Dutertre, Bruno Robisson and Assia Tria</i> 2. Circuit Simulation for Fault Sensitivity Analysis and its Application to Cryptographic LSI <i>Takeshi Sugawara, Daisuke Suzuki and Toshihiro Katashita</i></p>
10:45-11:10	<p>Coffee break</p>
11:10-12:25	<p>Session 2: Differential fault analysis <i>Chair: Francesco Regazzoni</i> 1. Differential Fault Analysis on Lightweight Blockciphers with Statistical Cryptanalysis Techniques <i>Dawu Gu, Juanru Li, Sheng Li, Zheng Guo and Junrong Liu</i> 2. A DFA on AES based on the Entropy of Error Distributions <i>Ronan Lashermes, Guillaume Reymond, Jean-Max Dutertre, Jacques Fournier, Bruno Robisson and Assia Tria</i> 3. Differential Fault Analysis on Groestl <i>Wieland Fischer and Christian A. Reuter</i></p>

12:25-13:40	Lunch
13:40-14:20	<p>2nd Invited Talk: <i>Chair: Helena Handschuh</i></p> <p>It's not my Fault – on Fault Attacks on Symmetric Cryptography</p> <p><i>Bart Preneel</i></p>
14:20-15:10	<p>Session 3: Fault analysis <i>Chair: Luca Breveglieri</i></p> <p>1. Combined Fault and Side-Channel Attacks on the AES Key Schedule <i>François Dassance and Alexandre Venelli</i></p> <p>2. Harnessing biased Faults in Attacks on ECC-based Signature Schemes <i>Celine Blondeau, Kimmo Jarvinen, Dan Page and Michael Tunstall</i></p>
15:10-15:35	Coffee break
15:35-16:50	<p>Session 4: Countermeasures <i>Chair: Wieland Fischer</i></p> <p>1. On the Need of Randomness in Fault Attack Countermeasures – Application to AES <i>Adrian Thillard, Thomas Roche and Victor Lomne</i></p> <p>2. An Efficient Countermeasure against Fault Sensitivity Analysis using Configurable Delay Block <i>Sho Endo, Yang Li, Naofumi Homma, Kazuo Sakiyama, Kazuo Ohta and Takafumi Aoki</i></p> <p>3. Random Active Shield <i>Sylvain Guilley, Sébastien Briaes, Thibault Porteboeuf, Jean-Luc Danger, Jean-Michel Cioranescu and David Naccache</i></p>
16:50-17:00	Closing remarks and Farewell